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Kind regards,

Team Nexperia



# PBSS9110D

100 V, 1 A PNP low  $V_{CEsat}$  (BISS) transistor

Rev. 03 — 22 November 2009

Product data sheet

## 1. Product profile

### 1.1 General description

PNP low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS8110D.

### 1.2 Features

- Low collector-emitter saturation voltage  $V_{CEsat}$
- High collector current capability  $I_C$  and  $I_{CM}$
- High collector current gain ( $h_{FE}$ ) at high  $I_C$
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Automotive applications

### 1.4 Quick reference data

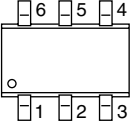
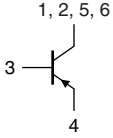
Table 1. Quick reference data

| Symbol      | Parameter                                  | Conditions                       | Min   | Typ | Max  | Unit       |
|-------------|--|----------------------------------|-------|-----|------|------------|
| $V_{CEO}$   | collector-emitter voltage                  | open base                        | -     | -   | -100 | V          |
| $I_C$       | collector current                          |                                  | -     | -   | -1   | A          |
| $I_{CM}$    | peak collector current                     | single pulse;<br>$t_p \leq 1$ ms | -     | -   | -3   | A          |
| $R_{CEsat}$ | collector-emitter<br>saturation resistance | $I_C = -1$ A;<br>$I_B = -100$ mA | [1] - | 170 | 320  | m $\Omega$ |

[1] Pulse test:  $t_p \leq 300$   $\mu$ s;  $\delta \leq 0.02$ .

## 2. Pinning information

Table 2. Pinning

| Pin        | Description | Simplified outline  | Symbol  |
|------------|-------------|---|---|
| 1, 2, 5, 6 | collector   |  |  |
| 3          | base        |   |   |
| 4          | emitter     |   |   |

*sym030*

## 3. Ordering information

Table 3. Ordering information

| Type number | Package |  |         |
|-------------|---------|--|---------|
|             | Name    | Description                                      | Version |
| PBSS9110D   | SC-74   | plastic surface-mounted package (TSOP6); 6 leads | SOT457  |

## 4. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| PBSS9110D   | A7           |

## 5. Limiting values

Table 5. Limiting values

*In accordance with the Absolute Maximum Rating System (IEC 60134).*

| Symbol    | Parameter                 | Conditions                       | Min | Max  | Unit |    |
|-----------|---------------------------|----------------------------------|-----|------|------|----|
| $V_{CBO}$ | collector-base voltage    | open emitter                     | -   | -120 | V    |    |
| $V_{CEO}$ | collector-emitter voltage | open base                        | -   | -100 | V    |    |
| $V_{EBO}$ | emitter-base voltage      | open collector                   | -   | -5   | V    |    |
| $I_C$     | collector current         |                                  | -   | -1   | A    |    |
| $I_{CM}$  | peak collector current    | single pulse;<br>$t_p \leq 1$ ms | -   | -3   | A    |    |
| $I_B$     | base current              |                                  | -   | -0.3 | A    |    |
| $P_{tot}$ | total power dissipation   | $T_{amb} \leq 25$ °C             | [1] | -    | 300  | mW |
|           |                           |                                  | [2] | -    | 550  | mW |
|           |                           |                                  | [3] | -    | 700  | mW |

**Table 5. Limiting values ...continued**

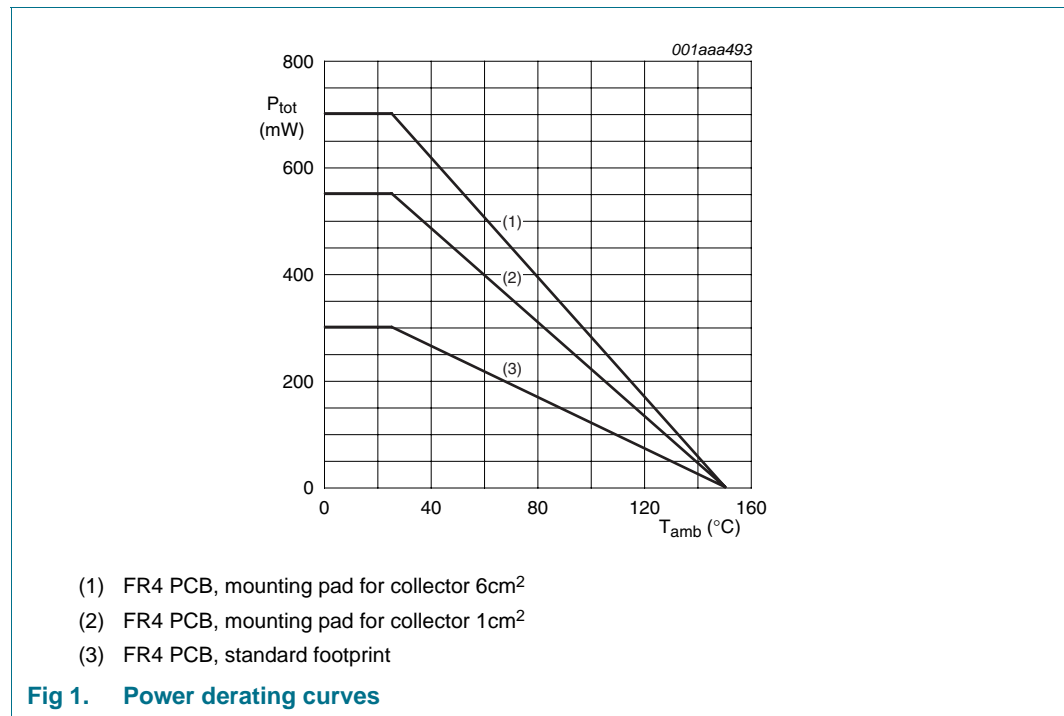
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol    | Parameter            | Conditions | Min | Max  | Unit |
|-----------|----------------------|------------|-----|------|------|
| $T_j$     | junction temperature |            | -   | 150  | °C   |
| $T_{amb}$ | ambient temperature  |            | -65 | +150 | °C   |
| $T_{stg}$ | storage temperature  |            | -65 | +150 | °C   |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm<sup>2</sup>.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6cm<sup>2</sup>.



**Fig 1. Power derating curves**

## 6. Thermal characteristics

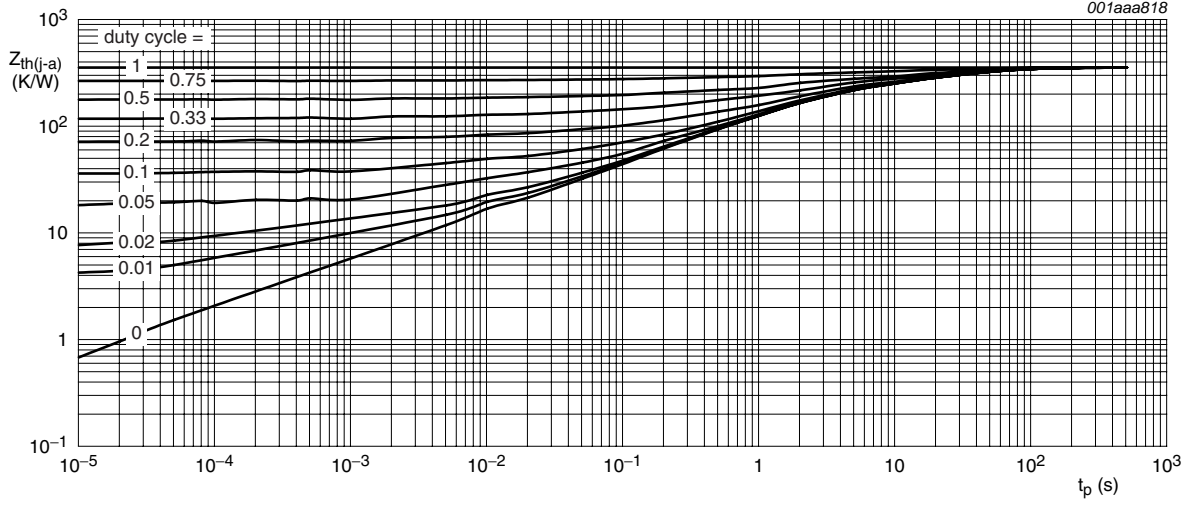
**Table 6. Thermal characteristics**

| Symbol         | Parameter  | Conditions  | Min | Typ | Max | Unit |     |
|----------------|--|-------------|-----|-----|-----|------|-----|
| $R_{th(j-a)}$  | thermal resistance from junction to ambient      | in free air | [1] | -   | -   | 416  | K/W |
|                |  |             | [2] | -   | -   | 227  | K/W |
|                |  |             | [3] | -   | -   | 178  | K/W |
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point |             | -   | -   | 83  | K/W  |     |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

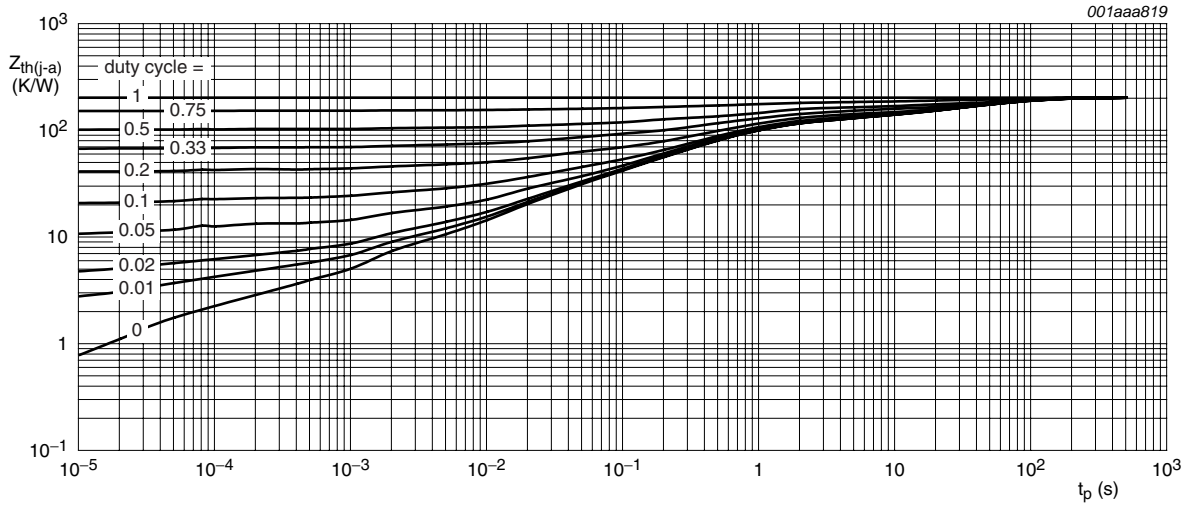
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm<sup>2</sup>.

[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6cm<sup>2</sup>.



FR4 PCB, standard footprint

Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for collector 1cm<sup>2</sup>

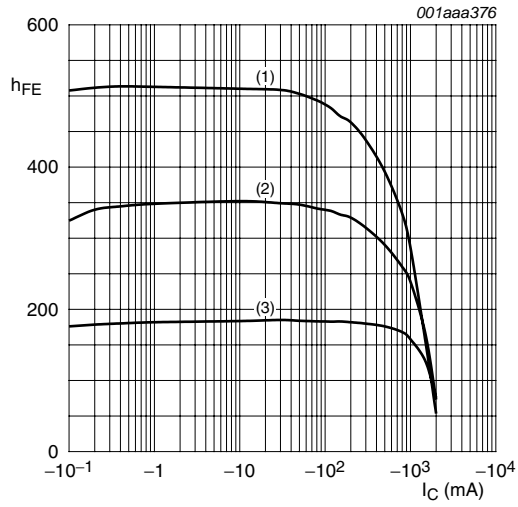
Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 7. Characteristics

**Table 7. Characteristics**
 $T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified.

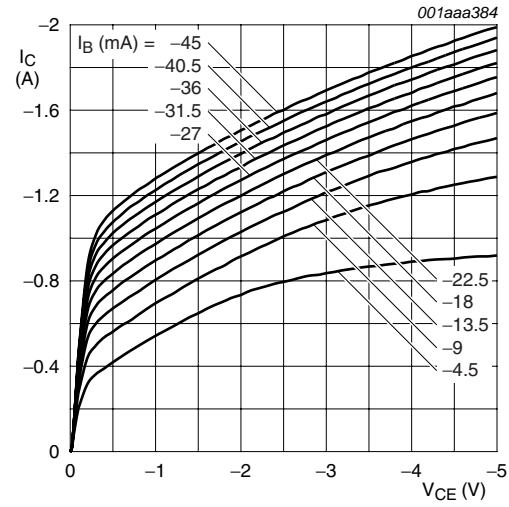
| Symbol      | Parameter                               | Conditions   | Min     | Typ | Max  | Unit             |
|-------------|---|--|---------|-----|------|------------------|
| $I_{CBO}$   | collector-base cut-off current          | $V_{CB} = -80\text{ V}; I_E = 0\text{ A}$  | -       | -   | -100 | nA               |
|             |   | $V_{CB} = -80\text{ V}; I_E = 0\text{ A}; T_j = 150\text{ }^{\circ}\text{C}$                       | -       | -   | -50  | $\mu\text{A}$    |
| $I_{CES}$   | collector-emitter cut-off current       | $V_{CE} = -80\text{ V}; V_{BE} = 0\text{ V}$   | -       | -   | -100 | nA               |
| $I_{EBO}$   | emitter-base cut-off current            | $V_{EB} = -4\text{ V}; I_C = 0\text{ A}$   | -       | -   | -100 | nA               |
| $h_{FE}$    | DC current gain                         | $V_{CE} = -5\text{ V}; I_C = -1\text{ mA}$   | 150     | -   | -    |                  |
|             |   | $V_{CE} = -5\text{ V}; I_C = -250\text{ mA}$   | 150     | -   | -    |                  |
|             |   | $V_{CE} = -5\text{ V}; I_C = -0.5\text{ A}$  | [1] 150 | -   | 450  |                  |
|             |   | $V_{CE} = -5\text{ V}; I_C = -1\text{ A}$  | [1] 125 | -   | -    |                  |
| $V_{CEsat}$ | collector-emitter saturation voltage    | $I_C = -250\text{ mA}; I_B = -25\text{ mA}$  | -       | -   | -120 | mV               |
|             |   | $I_C = -0.5\text{ A}; I_B = -50\text{ mA}$   | [1] -   | -   | -180 | mV               |
|             |   | $I_C = -1\text{ A}; I_B = -100\text{ mA}$  | [1] -   | -   | -320 | mV               |
| $R_{CEsat}$ | collector-emitter saturation resistance | $I_C = -1\text{ A}; I_B = -100\text{ mA}$  | [1] -   | 170 | 320  | $\text{m}\Omega$ |
| $V_{BEsat}$ | base-emitter saturation voltage         | $I_C = -1\text{ A}; I_B = -100\text{ mA}$  | [1] -   | -   | -1.1 | V                |
| $V_{BEon}$  | base-emitter turn-on voltage            | $V_{CE} = -5\text{ V}; I_C = -1\text{ A}$  | -       | -   | -1.0 | V                |
| $t_d$       | delay time                              | $V_{CC} = -10\text{ V}; I_C = -0.5\text{ A}; I_{Bon} = -0.025\text{ A}; I_{Boff} = 0.025\text{ A}$ | -       | 20  | -    | ns               |
| $t_r$       | rise time                               |  | -       | 60  | -    | ns               |
| $t_{on}$    | turn-on time                            |  | -       | 80  | -    | ns               |
| $t_s$       | storage time                            |  | -       | 290 | -    | ns               |
| $t_f$       | fall time                               |  | -       | 120 | -    | ns               |
| $t_{off}$   | turn-off time                           |  | -       | 410 | -    | ns               |
| $f_T$       | transition frequency                    | $V_{CE} = -10\text{ V}; I_C = -50\text{ mA}; f = 100\text{ MHz}$                                   | 100     | -   | -    | MHz              |
| $C_C$       | collector capacitance                   | $V_{CB} = -10\text{ V}; I_E = I_e = 0\text{ A}; f = 1\text{ MHz}$                                  | -       | -   | 17   | pF               |

[1] Pulse test:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0.02$ .



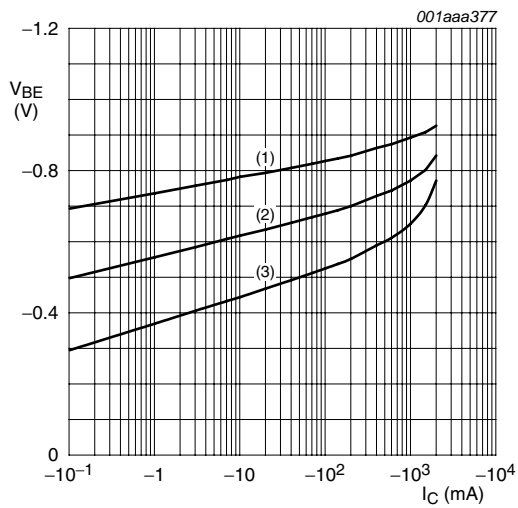
$V_{CE} = -10$  V  
 (1)  $T_{amb} = 100$  °C  
 (2)  $T_{amb} = 25$  °C  
 (3)  $T_{amb} = -55$  °C

**Fig 4. DC current gain as a function of collector current; typical values**



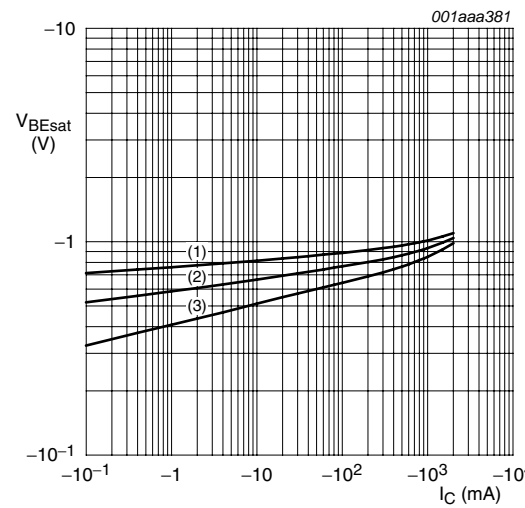
$T_{amb} = 25$  °C

**Fig 5. Collector current as a function of collector-emitter voltage; typical values**



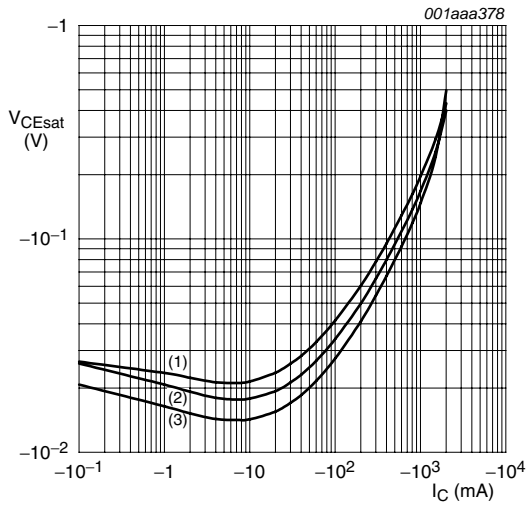
$V_{CE} = -10$  V  
 (1)  $T_{amb} = -55$  °C  
 (2)  $T_{amb} = 25$  °C  
 (3)  $T_{amb} = 100$  °C

**Fig 6. Base-emitter voltage as a function of collector current; typical values**



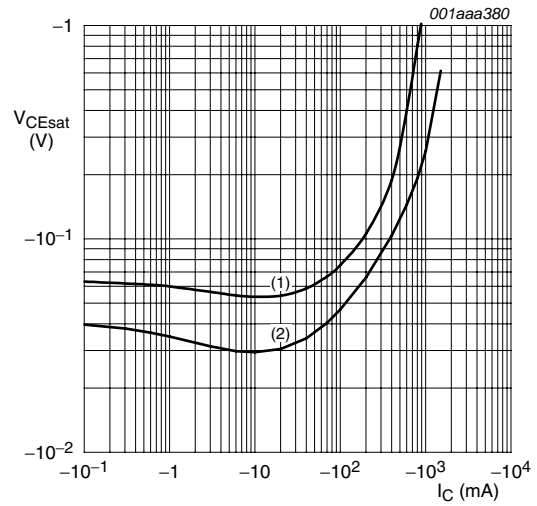
$I_C/I_B = 10$   
 (1)  $T_{amb} = -55$  °C  
 (2)  $T_{amb} = 25$  °C  
 (3)  $T_{amb} = 100$  °C

**Fig 7. Base-emitter saturation voltage as a function of collector current; typical values**



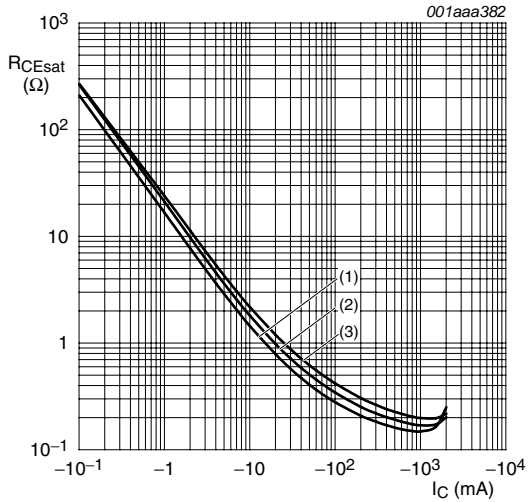
$I_C/I_B = 10$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values**



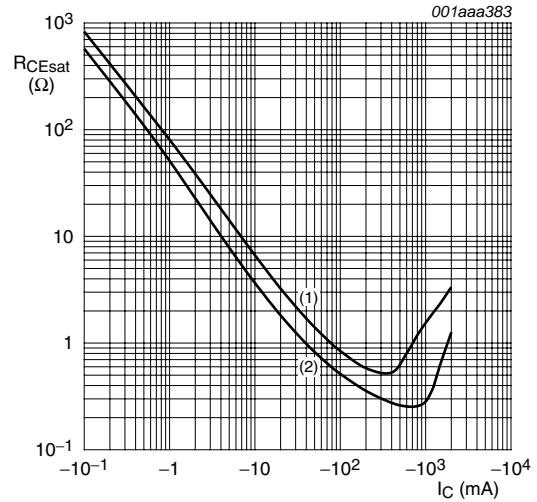
$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 50$   
 (2)  $I_C/I_B = 20$

**Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values**



$I_C/I_B = 10$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

**Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values**



$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 50$   
 (2)  $I_C/I_B = 20$

**Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values**



8. Test information

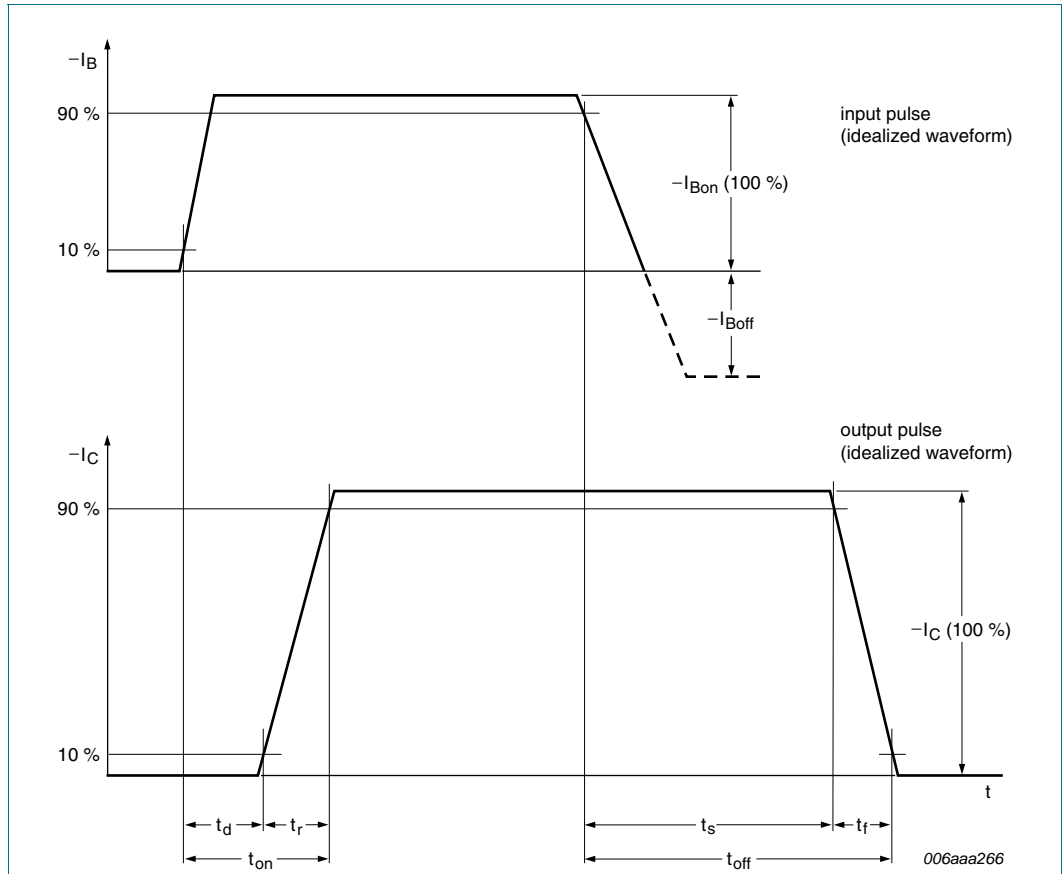
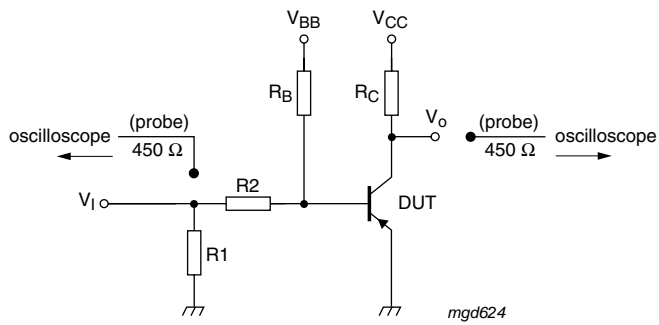


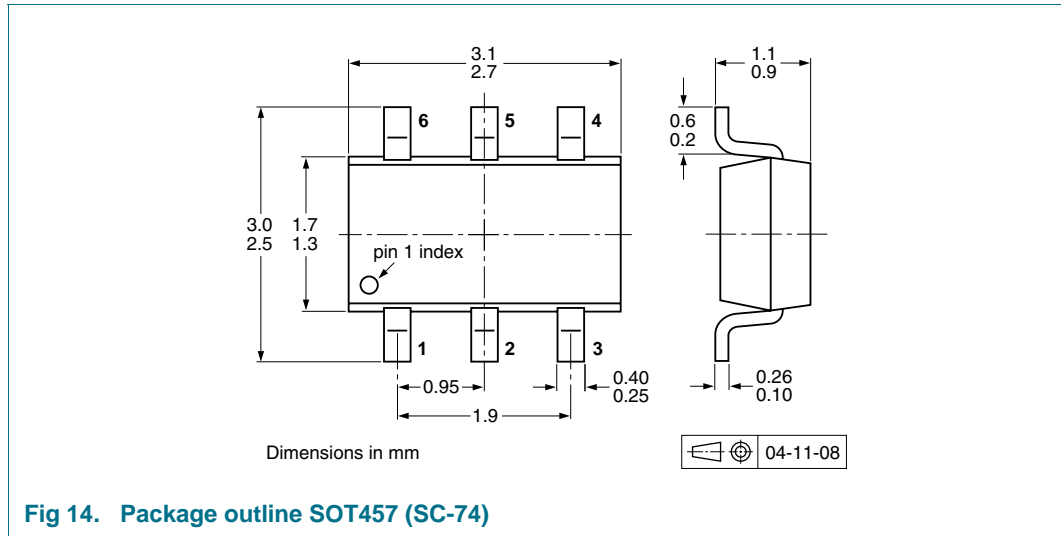
Fig 12. BISS transistor switching time definition



$V_{CC} = -10\text{ V}$ ;  $I_C = -0.5\text{ A}$ ;  $I_{Bon} = -0.025\text{ A}$ ;  $I_{Boff} = 0.025\text{ A}$

Fig 13. Test circuit for switching times

## 9. Package outline



## 10. Packing information

**Table 8. Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.<sup>[1]</sup>

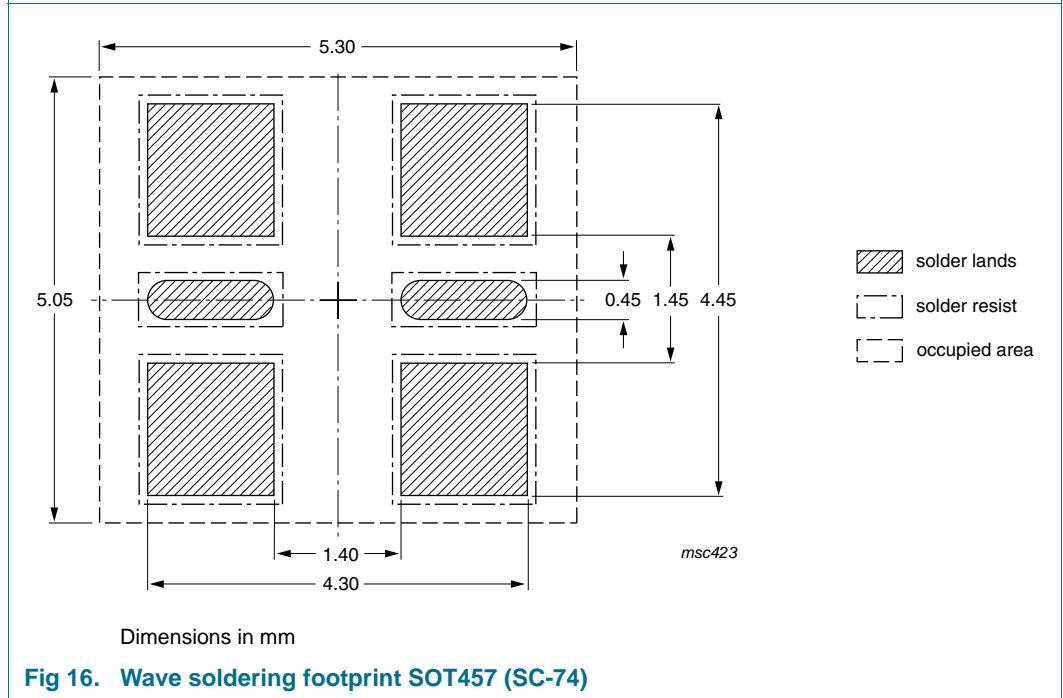
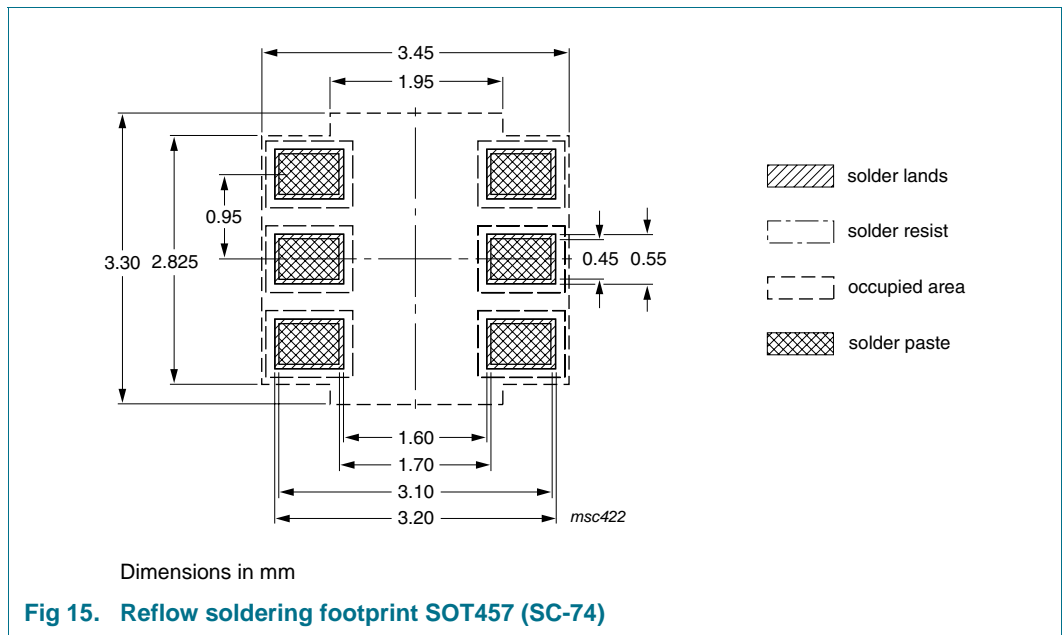
| Type number | Package | Description                        | Packing quantity    |       |
|-------------|---------|------------------------------------|---------------------|-------|
|             |         |                                    | 3000                | 10000 |
| PBSS9110D   | SOT457  | 4 mm pitch, 8 mm tape and reel; T1 | <sup>[2]</sup> -115 | -135  |
|             |         | 4 mm pitch, 8 mm tape and reel; T2 | <sup>[3]</sup> -125 | -165  |

[1] For further information and the availability of packing methods, see [Section 14](#).

[2] T1: normal taping

[3] T2: reverse taping

11. Soldering



## 12. Revision history

Table 9. Revision history

| Document ID    | Release date | Data sheet status  | Change notice | Supersedes  |
|----------------|--------------|--|---------------|-------------|
| PBSS9110D_3    | 20091122     | Product data sheet   | -             | PBSS9110D_2 |
| Modifications: |              | <ul style="list-style-type: none"><li>This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content.</li><li><a href="#">Figure 16 "Wave soldering footprint SOT457 (SC-74)":</a> updated</li></ul> |               |             |
| PBSS9110D_2    | 20060713     | Product data sheet   | -             | PBSS9110D_1 |
| PBSS9110D_1    | 20040611     | Objective data sheet   | -             | -           |

## 13. Legal information

### 13.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition  |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet    | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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